

INTERNATIONAL ELECTROTECHNICAL COMMISSION
COMMISSION ÉLECTROTECHNIQUE INTERNATIONALE

IEC 61000-4-11
Edition 3.0 2020-01

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ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current up to 16 A per phase

COMPATIBILITE ELECTROMAGNETIQUE (CEM) –

Partie 4-11: Techniques d'essai et de mesure – Essais d'immunité aux creux de tension, coupures brèves et variations de tension pour les appareils à courant d'entrée inférieur ou égal à 16 A par phase

CORRIGENDUM 2

Corrections to the French version appear after the English text.

Les corrections à la version française sont données après le texte anglais.

5.3 Voltage variations (optional)

Replace the heading, as modified by Corrigendum 1, with the following new heading:

5.3 Voltage variations

7 Test set-up

Replace the second paragraph with the following new paragraph:

The test set-ups are defined for the three types of phenomena described in this document.

9 Evaluation of test results

Replace the note with the following new note:

NOTE The performance levels can be different for voltage dip tests and short interruption tests as well as for voltage variations tests.